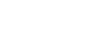


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Texas Instruments



DRV8884

ZHCSEP5D - JANUARY 2016 - REVISED NOVEMBER 2018

DRV8884 具有集成电流检测功能的 1.0A 步进电机驱动器

Technical

Documents

1 特性

- 脉宽调制 (PWM) 微步进电机驱动器
 - 最高 1/16 微步进
- 非循环和标准 ½ 步进模式
- 集成电流检测功能
 - 无需检测电阻
 - ±6.25% 满量程电流精度
- 慢速衰减和混合衰减选项
- 8.0V 至 37V 的工作电源电压范围
- 低 R_{DS(ON)}: 24V 和 25°C 条件下为 1.4Ω HS + LS
- 高电流容量
 - 每个桥的满量程为 1.0A
 - 每个桥的均方根 (rms) 为 0.7A
- 固定的关断时间 PWM 斩波
- 简单的 STEP/DIR 接口
- 低电流休眠模式 (20μA)
- 小型封装和外形尺寸
 - 24 引脚散热薄型小外形尺寸 (HTSSOP) PowerPAD™封装
 - 28 WQFN 封装
- 保护 特性
 - VM 欠压锁定 (UVLO)
 - 电荷泵欠压 (CPUV)
 - 过流保护 (OCP)
 - 热关断 (TSD)
 - 故障条件指示引脚 (nFAULT)

- 2 应用
- 多功能打印机和扫描仪
- 激光束打印机
- 3D 打印机
- 自动取款机和验钞机
- 视频安保摄像机
- 办公自动化设备
- 工厂自动化和机器人

3 说明

DRV8884 器件是一款面向工业设备应用的步进电机 驱动器。此器件具有两个 N 沟道功率金属氧化物半导体场效应晶体管 (MOSFET) H 桥驱动器、一个微步进分度器以及集成电流检测功能。DRV8884 能够驱动高达 1.0A 的满量程输出电流或 0.7A rms 输出电流(采用适当的印刷电路板 (PCB) 接地层进行散热,电压为 24V, $T_A = 25^{\circ}$ C)。

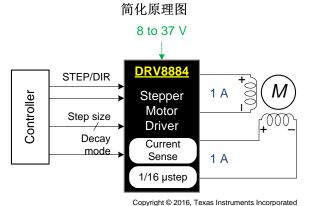
DRV8884 集成了电流检测功能,消除了对两个外部检测电阻的需求。

STEP/DIR 引脚提供简单的控制接口。器件可配置为多种步进模式,从全步进模式到 1/16 步进模式。凭借专用的 nSLEEP 引脚,该器件可提供一种低功耗的休眠模式,从而实现超低静态电流待机。

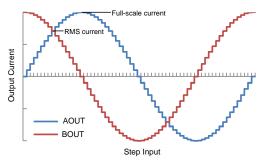
该器件内置以下保护功能:欠压、电荷泵故障、过流、 短路以及过热保护。故障状态通过 nFAULT 引脚指 示。

	器件信息の	
器件型号	封装	封装尺寸(标称值)
DRV8884	HTSSOP (24)	7.80mm × 4.40mm
DR V 0004	WQFN (28)	5.50mm × 3.5mm

(1) 如需了解所有可用封装,请参阅数据表末尾的可订购产品附录。



微步进电流波形



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4 修订历史记录

注: 之前版本的页码可能与当前版本有所不同。

Changes from Revision C (July 2018) to Revision D			
• 己更改 器件状态从"预告信息"改为"生产数据"	1		
Changes from Revision B (April 2016) to Revision C	Page		

•	已添加 WQFN 封装选项	. 1
•	Deleted and internal indexer from the description of the ENABLE pin in the Pin Functions table	. 3
•	Changed until ENABLE is deasserted to until ENABLE is asserted in the Device Functional Modes section	26
•	已添加 接收文档更新通知部分	32

Changes from Revision A (March 2016) to Revision B

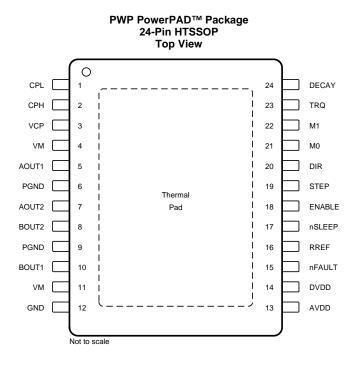
•	Updated R _{PD} and R _{PU} values	. 6
•	Fixed chopping current equation	18
•	Added "Controlling RREF with a PWM Resource"	18
•	Fixed resistance values in tri-level input pin diagram	24

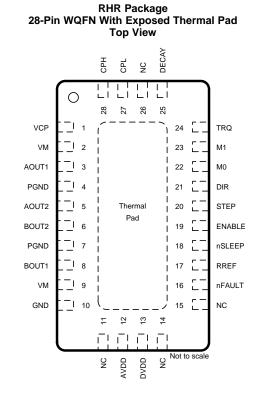
Changes from Original (January 2016) to Revision A

•	己更改器件状态"产品预览"至"量产数据"		1
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5 Pin Configuration and Functions





Pin Functions

PIN		PIN		PIN										
NAME NO.		NO.		NO.		NO.		NO.		NO.		NO.		DESCRIPTION
		WQFN												
AOUT1	5	3	0	Winding A output. Connect to stepper motor winding.										
AOUT2	7	5	0	winding A duput. Connect to stepper motor winding.										
AVDD	13	12	PWR	Internal regulator. Bypass to GND with a X5R or X7R, 0.47-µF, 6.3-V ceramic capacitor.										
BOUT1	10	8	0	Winding B output. Connect to stepper motor winding.										
BOUT2	8	6	0	winding B output. Connect to stepper motor winding.										
CPH	2	28	PWR											
CPL	1	27	PWR	Charge pump switching node. Connect a X5R or X7R, 0.022-µF, VM-rated ceramic capacitor from CPH to CPL.										
DECAY	24	25	I	Decay-mode setting. Sets the decay mode (see the <i>Decay Modes</i> section). Decay mode can be adjusted during operation.										
DIR	20	21	I	Direction input. Logic level sets the direction of stepping; internal pulldown resistor.										
DVDD	14	13	PWR	Internal regulator. Bypass to GND with a X5R or X7R, 0.47-µF, 6.3-V ceramic capacitor.										
ENABLE	18	19	I	Enable driver input. Logic high to enable device outputs; logic low to disable; internal pulldown resistor.										
GND	12	10	PWR	Device ground. Connect to system ground.										
M0	21	22												
M1	22	23	I	Microstepping mode-setting. Sets the step mode; tri-level pins; sets the step mode; internal pulldown resistor.										
		11												
NC		14		No connect. No internal connection										
NC	_	15	_											
		26												
PGND	6	4	PWR	Power ground Connect to system ground										
PGND	9	7	PWR	Power ground. Connect to system ground.										
RREF	16	17	I	Current-limit analog input. Connect a resistor to ground to set full-scale regulation current.										

(1) I = input, O = output, PWR = power, OD = open-drain

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STRUMENTS

XAS

Pin Functions (continued)

	PIN				
NAME	NO.		TYPE ⁽¹⁾	DESCRIPTION	
NAME	HTSSOP WQFN				
STEP	19	20	I	Step input. A rising edge causes the indexer to advance one step; internal pulldown resistor.	
TRQ	23	24	Ι	Current-scaling control. Scales the output current; tri-level pin.	
VCP	3	1	PWR	Charge pump output. Connect a X5R or X7R, 0.22-µF, 16-V ceramic capacitor to VM.	
VM	4	2 PWR		Power supply. Connect to motor supply voltage and bypass to GND with two 0.01-µF ceramic capacitors (one for	
VIVI	11	9	PVVR	each pin) plus a bulk capacitor rated for VM.	
nFAULT	15	16	OD	Fault indication. Pulled logic low with fault condition; open-drain output requires an external pullup resistor.	
nSLEEP	17	18	Ι	Sleep mode input. Logic high to enable device; logic low to enter low-power sleep mode; internal pulldown resistor.	

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) ⁽¹⁾

	MIN	MAX	UNIT
Power supply voltage (VM)	-0.3	40	V
Power supply voltage ramp rate (VM)	0	2	V/µs
Charge pump voltage (VCP, CPH)	-0.3	VM + 7	V
Charge pump negative switching pin (CPL)	-0.3	VM	V
Internal regulator voltage (DVDD)	-0.3	3.8	V
Internal regulator current output (DVDD)	0	1	mA
Internal regulator voltage (AVDD)	-0.3	5.7	V
Control pin voltage (STEP, DIR, ENABLE, nFAULT, M0, M1, DECAY, TRQ, nSLEEP)	-0.3	5.7	V
Open drain output current (nFAULT)	0	10	mA
Current limit input pin voltage (RREF)	-0.3	6.0	V
Continuous phase node pin voltage (AOUT1, AOUT2, BOUT1, BOUT2)	-0.7	VM + 0.7	V
Peak drive current (AOUT1, AOUT2, BOUT1, BOUT2)		1.7	А
Operating junction temperature, T _J	-40	150	°C
Storage temperature, T _{stg}	-65	150	°C

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings

			VALUE	UNIT
	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	N/	
V(ESD)	V _(ESD) Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±500	V

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
VM	Power supply voltage	8	37	V
VCC	Logic level input voltage	0	5.3	V
f_{PWM}	Applied STEP signal (STEP)	0	100 (1)	kHz
I _{DVDD}	DVDD external load current	0	1 ⁽²⁾	mA
I _{FS}	Motor full scale current	0	1.0	A
I _{rms}	Motor rms current	0	0.7	А
T _A	Operating ambient temperature	-40	125	°C

STEP input can operate up to 500 kHz, but system bandwidth is limited by the motor load
 Power dissipation and thermal limits must be observed

6.4 Thermal Information

		DRV		
	THERMAL METRIC ⁽¹⁾	PWP (HTSSOP)	RHR (WQFN)	UNIT
		24 PINS	28 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	36.1	33.6	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	18.3	23.8	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	15.8	12.7	°C/W
ΨJT	Junction-to-top characterization parameter	0.4	0.3	°C/W
ΨЈВ	Junction-to-board characterization parameter	15.7	12.6	°C/W
R _{0JC(bot)}	Junction-to-case (bottom) thermal resistance	1.1	3.7	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

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6.5 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
POWER	SUPPLIES (VM, DVDD, AVDD)					
VVM	VM operating voltage		8		37	V
I _{VM}	VM operating supply current	VM ≈ 8 to 35 V, ENABLE = 1, nSLEEP = 1, No motor load		5	8	mA
	\/M close mode cuenty current	$nSLEEP = 0; T_A = 25^{\circ}C$			20	
I _{VMQ}	VM sleep mode supply current	$nSLEEP = 0; T_A = 125^{\circ}C^{(1)}$			40	μA
t _{SLEEP}	Sleep time	nSLEEP = 0 to sleep-mode		50	200	μS
t _{WAKE}	Wake-up time	nSLEEP = 1 to output transition		0.85	1.5	ms
t _{ON}	Turn-on time	VM > UVLO to output transition		0.85	1.5	ms
V _{DVDD}	Internal regulator voltage	0- to 1-mA external load	2.9	3.3	3.6	V
V _{AVDD}	Internal regulator voltage	No external load	4.5	5.0	5.5	V
CHARGE	EPUMP (VCP, CPH, CPL)	·				
V _{VCP}	VCP operating voltage	VM > 8 V		VM + 5.5		V
LOGIC-LI	EVEL INPUTS (STEP, DIR, ENABL	E, nSLEEP, M1)				
V _{IL}	Input logic low voltage		0		0.8	V
V _{IH}	Input logic high voltage		1.6		5.3	V
V _{HYS}	Input logic hysteresis		100			mV
IIL	Input logic low current	VIN = 0 V	-1		1	μA
I _{IH}	Input logic high current	VIN = 5.0 V			100	μA
R _{PD}	Pulldown resistance	To GND		100		kΩ
t _{PD}	Propagation delay	STEP to current change			1.2	μS
TRI-LEVE	EL INPUT (M0, TRQ)		ľ			
V _{IL}	Tri-level input logic low voltage		0		0.65	V
V _{IZ}	Tri-level input Hi-Z voltage			1.1		V
V _{IH}	Tri-level input logic high voltage		1.5		5.3	V
I _{IL}	Tri-level input logic low current	VIN = 0 V	-80			μA
I _{IZ}	Tri-level input Hi-Z current	VIN = 1.3 V	-5		5	μA
I _{IH}	Tri-level input logic high current	VIN = 5.0 V			155	μA
R _{PD}	Tri-level pulldown resistance	To GND	18	32	50	kΩ
R _{PU}	Tri-level pullup resistance	To DVDD	30	60	90	kΩ
QUAD-LE	EVEL INPUT (DECAY)					
V _{I1}	Quad-level input voltage 1	5% resistor 5 k Ω to GND	0.07	0.11	0.13	V
V _{I2}	Quad-level input voltage 2	5% resistor 15 k Ω to GND	0.24	0.32	0.40	V
V _{I3}	Quad-level input voltage 3	5% resistor 45 k Ω to GND	0.71	0.97	1.20	V
V _{I4}	Quad-level input voltage 4	5% resistor 135 k Ω to GND	2.12	2.90	3.76	V
I _O	Output current	To GND	14	22	30	μA
	L OUTPUTS (nFAULT)	1				
V _{OL}	Output logic low voltage	$I_0 = 1 \text{ mA}, R_{PULLUP} = 4.7 \text{ k}\Omega$			0.5	V
I _{OH}	Output logic high leakage	$V_0 = 5.0 \text{ V}, \text{ R}_{\text{PULLUP}} = 4.7 \text{ k}\Omega$	-1		+1	μA

(1) Not tested in production; limits are based on characterization data



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Electrical Characteristics (continued)

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
MOTOR DR	RIVER OUTPUTS (AOUT1, AOUT	r2, BOUT1, BOUT2)				
R _{DS(ON)}	High-side FET on resistance	VM = 24 V, I = 1 A, T _A = 25°C		716	798	mΩ
R _{DS(ON)}	Low-side FET on resistance	VM = 24 V, I = 1 A, T _A = 25°C		684	749	mΩ
t _{RISE} ⁽²⁾	Output rise time			100		ns
t _{FALL} ⁽²⁾	Output fall time			100		ns
t _{DEAD} ⁽²⁾	Output dead time			200		ns
V _d ⁽²⁾	Body diode forward voltage	I _{OUT} = 0.5 A		0.7	1.0	V
PWM CURF	RENT CONTROL (RREF)					
A _{RREF}	RREF transimpedance gain		28.1	30	31.9	kAΩ
V _{RREF}	RREF voltage	RREF = 27 to 132 kΩ	1.18	1.232	1.28	V
t _{OFF}	PWM off-time			20		μS
C _{RREF}	Equivalent capacitance on RREF				10	pF
		I _{RREF} = 1.0 A, 63% to 100% current setting		1.5		
t _{BLANK}	PWM blanking time	I _{RREF} = 1.0 A, 0% to 63% current setting		1.0		μs
		I _{RREF} = 1.0 A, 10% to 20% current setting, 1% reference resistor	-25%		25%	
ΔI_{TRIP}	Current trip accuracy	I _{RREF} = 1.0 A, 20% to 63% current setting, 1% reference resistor	-12.5%		12.5%	
		I _{RREF} = 1.0 A, 71% to 100% current setting, 1% reference resistor	-6.25%		6.25%	
PROTECTI	ON CIRCUITS				·	
V	VM UVLO	VM falling; UVLO report			7.8	V
V _{UVLO}		VM rising; UVLO recovery			8.0	V
V _{UVLO,HYS}	Undervoltage hysteresis	Rising to falling threshold		100		mV
V _{CPUV}	Charge pump undervoltage	VCP falling; CPUV report		VM + 2.0		V
I _{OCP}	Overcurrent protection trip level	Current through any FET	1.7			А
t _{OCP}	Overcurrent deglitch time		1.3	1.9	2.8	μS
t _{RETRY}	Overcurrent retry time		1		1.6	ms
T _{TSD} ⁽²⁾	Thermal shutdown temperature	Die temperature T _J	150			°C
T _{HYS} ⁽²⁾	Thermal shutdown hysteresis	Die temperature TJ		20		°C

(2) Not tested in production; limits are based on characterization data

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6.6 Indexer Timing Requirements

 $T_A = 25^{\circ}C$, over recommended operating conditions unless otherwise noted

NO.			MIN	MAX	UNIT
1	f_{STEP}	Step frequency		500 (1)	kHz
2	t _{WH(STEP)}	Pulse duration, STEP high	970		ns
3	t _{WL(STEP)}	Pulse duration, STEP low	970		ns
4	t _{SU(DIR, Mx)}	Setup time, DIR or USMx to STEP rising	200		ns
5	t _{H(DIR, Mx)}	Hold time, DIR or USMx to STEP rising	200		ns

(1) STEP input can operate up to 500 kHz, but system bandwidth is limited by the motor load

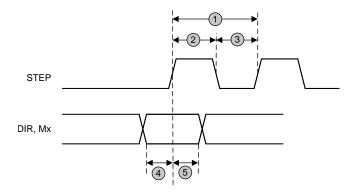
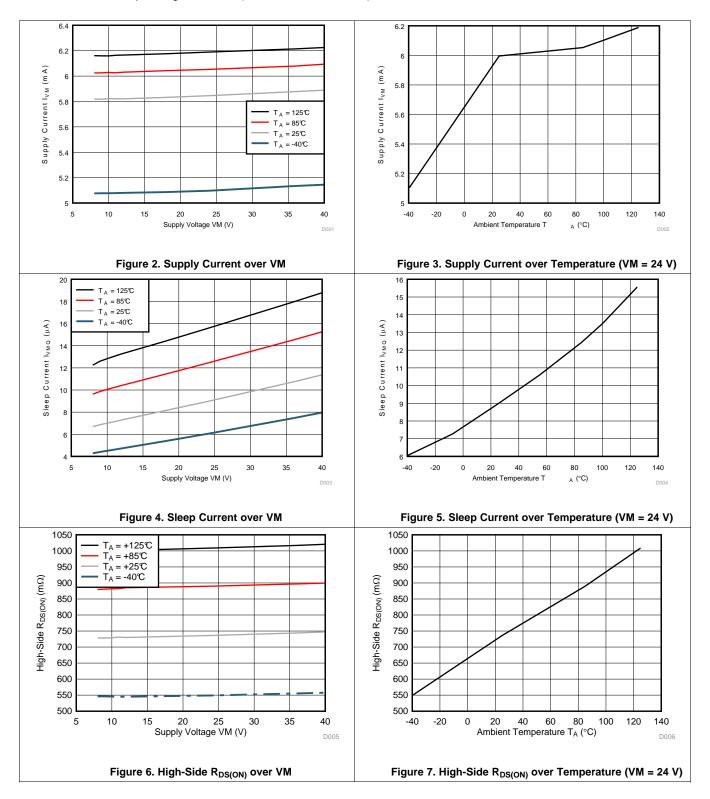


Figure 1. Timing Diagram



6.7 Typical Characteristics

Over recommended operating conditions (unless otherwise noted)



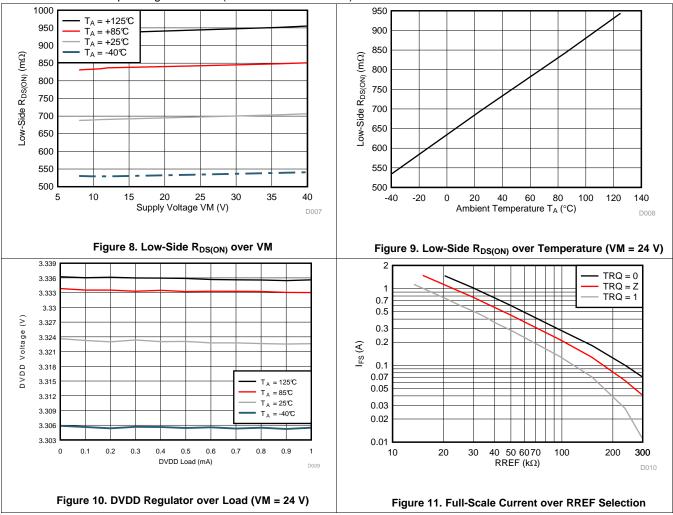
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Typical Characteristics (continued)

Over recommended operating conditions (unless otherwise noted)





7 Detailed Description

7.1 Overview

The DRV8884 is an integrated motor driver solution for bipolar stepper motors. The device integrates two NMOS H-bridges, integrated current sense and regulation circuitry, and a microstepping indexer. The DRV8884 can be powered with a supply voltage between 8 and 37 V, and is capable of providing an output current with up to 1.7-A peak, 1.0-A full-scale, or 0.7-A rms. Actual full-scale and rms current depends on ambient temperature, supply voltage, and PCB ground plane size.

The DRV8884 integrates current sense functionality, which eliminates the need for high-power external sense resistors. This integration does not dissipate the external sense resistor power, because the current sense functionality is not implemented using a resistor-based architecture. This functionality helps improve component cost, board size, PCB layout, and system power consumption.

A simple STEP/DIR interface allows easy interfacing to the controller circuit. The internal indexer is able to execute high-accuracy microstepping without requiring the processor to control the current level. The indexer is capable of full step and half step as well as microstepping to 1/4, 1/8, and 1/16. In addition to the standard half-stepping mode, a non-circular 1/2-stepping mode is available for increased torque output at higher motor rpm.

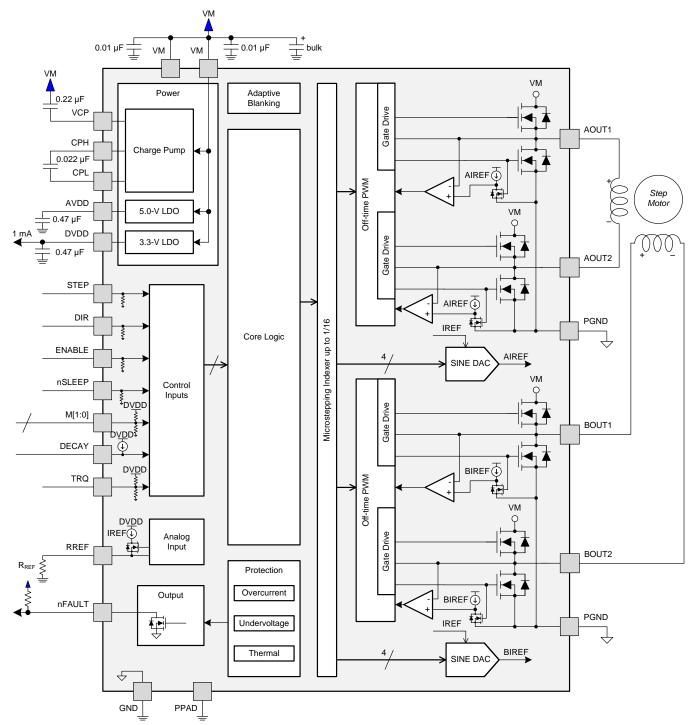
The current regulation is configurable with several decay modes of operation. The decay mode can be selected as a fixed slow, slow/mixed, or mixed decay. The slow/mixed decay mode uses slow decay on increasing steps and mixed decay on decreasing steps.

An adaptive blanking time feature automatically scales the minimum drive time with output current. This helps alleviate zero-crossing distortion by limiting the drive time at low-current steps.

A torque DAC feature allows the controller to scale the output current without needing to scale the reference resistor. The torque DAC is accessed using a digital input pin. This allows the controller to save power by decreasing the current consumption when not high current is not required.

A low-power sleep mode is included that allows the system to save power when not driving the motor.

7.2 Functional Block Diagram



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7.3 Feature Description

Table 1 lists the recommended external components for the DRV8884 device.

COMPONENT	PIN 1	PIN 2	RECOMMENDED		
C _{VM}	VM	GND	Two 0.01-µF ceramic capacitors rated for VM		
C _{VM}	VM	GND	Bulk electrolytic capacitor rated for VM		
C _{VCP}	VCP	VM	16-V, 0.22-µF ceramic capacitor		
C _{SW}	CPH	CPL	0.022-µF X7R capacitor rated for VM		
C _{AVDD}	AVDD	GND	6.3-V, 0.47-µF ceramic capacitor		
C _{DVDD}	DVDD	GND	6.3-V, 0.47-µF ceramic capacitor		
R _{nFAULT}	VCC ⁽¹⁾	nFAULT	>4.7 kΩ		
R _{REF}	RREF	GND	Resistor to limit chopping current must be installed. See the <i>Typical Application</i> section for value selection.		

Table 1. External Components

(1) VCC is not a pin on the DRV8884, but a VCC supply voltage pullup is required for open-drain output nFAULT; nFAULT may be pulled up to DVDD

7.3.1 Stepper Motor Driver Current Ratings

Stepper motor drivers can be classified using three different numbers to describe the output current: peak, rms, and full-scale.

7.3.1.1 Peak Current Rating

The peak current in a stepper driver is limited by the overcurrent protection trip threshold, I_{OCP} . The peak current describes any transient duration current pulse, for example when charging capacitance, when the overall duty cycle is very low. In general, the minimum value of I_{OCP} specifies the peak current rating of the stepper motor driver. For the DRV8884, the peak current rating is 1.7 A per bridge.

7.3.1.2 RMS Current Rating

The rms (average) current is determined by the thermal considerations of the IC. The rms current is calculated based on the R_{DS(ON)}, rise and fall time, PWM frequency, device quiescent current, and package thermal performance in a typical system at 25°C. The real operating rms current may be higher or lower depending on heatsinking and ambient temperature. For the DRV8884, the rms current rating is 0.7 A per bridge.

7.3.1.3 Full-Scale Current Rating

The full-scale current describes the top of the sinusoid current waveform while microstepping. Because the sinusoid amplitude is related to the rms current, the full-scale current is also determined by the thermal considerations of the IC. The full-scale current rating is approximately $\sqrt{2} \times I_{rms}$. The full-scale current is set by VREF, the sense resistor, and torque DAC when configuring the DRV8884 (see *Current Regulation* for details). For the DRV8884, the full-scale current rating is 1.0 A per bridge.

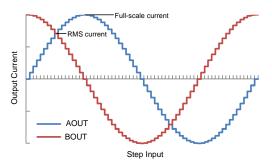


Figure 12. Full-Scale and rms Current

DRV8884

7.3.2 PWM Motor Drivers

The DRV8884 contains drivers for two full H-bridges. Figure 13 shows a block diagram of the circuitry.

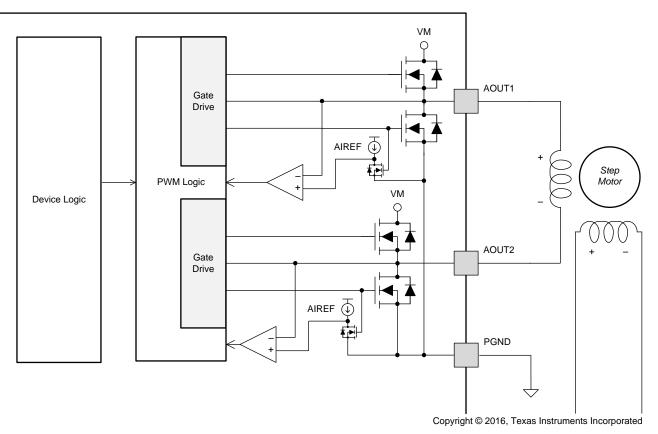


Figure 13. PWM Motor Driver Block Diagram

7.3.3 Microstepping Indexer

Built-in indexer logic in the DRV8884 allows a number of different stepping configurations. The Mx pins are used to configure the stepping format as shown in Table 2.

M1	MO	STEP MODE
0	0	Full step (2-phase excitation) with 71% current
0	1	1/16 step
1	0	1/2 step
1	1	1/4 step
0	Z	1/8 step
1	Z	Non-circular 1/2 step

Table 2	Microstepping	Settings
---------	---------------	----------

Table 3 shows the relative current and step directions for full-step through 1/16-step operation. The AOUT current is the sine of the electrical angle; BOUT current is the cosine of the electrical angle. Positive current is defined as current flowing from xOUT1 to xOUT2 while driving.

At each rising edge of the STEP input the indexer travels to the next state in the table (see Table 3). The direction is shown with the DIR pin logic high. If the DIR pin is logic low, the sequence is reversed.

On power-up or when exiting sleep mode, keep the STEP pin logic low, otherwise the indexer will advance one step.



Note that if the step mode is changed from full, 1/2, 1/4, 1/8, or 1/16 to full, 1/2, 1/4, 1/8, or 1/16 while stepping, the indexer will advance to the next valid state for the new MODE setting at the rising edge of STEP. If the step mode is changed from or to non-circular 1/2 step, the indexer will immediately go to the valid state for that mode.

The home state is an electrical angle of 45°. This state is entered after power-up, after exiting logic undervoltage lockout (UVLO), or after exiting sleep mode. Table 3 shows this state with the cells outlined in red.

FULL STEP	1/2 STEP	1/4 STEP	1/8 STEP	1/16 STEP	ELECTRICAL ANGLE (DEGREES)	AOUT CURRENT (% FULL-SCALE)	BOUT CURRENT (% FULL-SCALE)
	1	1	1	1	0.000°	0%	100%
				2	5.625°	10%	100%
			2	3	11.250°	20%	98%
				4	16.875°	29%	96%
		2	3	5	22.500°	38%	92%
				6	28.125°	47%	88%
			4	7	33.750°	56%	83%
				8	39.375°	63%	77%
1	2	3	5	9	45.000°	71%	71%
				10	50.625°	77%	63%
			6	11	56.250°	83%	56%
				12	61.875°	88%	47%
		4	7	13	67.500°	92%	38%
				14	73.125°	96%	29%
			8	15	78.750°	98%	20%
				16	84.375°	100%	10%
	3	5	9	17	90.000°	100%	0%
				18	95.625°	100%	-10%
			10	19	101.250°	98%	-20%
				20	106.875°	96%	-29%
		6	11	21	112.500°	92%	-38%
				22	118.125°	88%	-47%
			12	23	123.750°	83%	-56%
				24	129.375°	77%	-63%
2	4	7	13	25	135.000°	71%	-71%
				26	140.625°	63%	-77%
			14	27	146.250°	56%	-83%
				28	151.875°	47%	
		8	15	29	157.500°	38%	-92%
				30	163.125°	29%	-96%
			16	31	168.750°	20%	-98%
				32	174.375°	10%	-100%
	5	9	17	33	180.000°	0%	-100%
				34	185.625°	-10%	-100%
			18	35	191.250°	-20%	-98%
				36	196.875°	-29%	-96%
		10	19	37	202.500°	-38%	-92%
				38	208.125°	-47%	-88%
			20	39	213.750°	-56%	-83%
				40	219.375°	-63%	-77%

Table 3. Microstepping Relative Current per Step (DIR = 1)

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			-		. ,.	····· ·	
FULL STEP	1/2 STEP	1/4 STEP	1/8 STEP	1/16 STEP	ELECTRICAL ANGLE (DEGREES)	AOUT CURRENT (% FULL-SCALE)	BOUT CURRENT (% FULL-SCALE)
3	6	11	21	41	225.000°	-71%	-71%
				42	230.625°	-77%	-63%
			22	43	236.250°	-83%	-56%
				44	241.875°	-88%	-47%
		12	23	45	247.500°	-92%	-38%
				46	253.125°	-96%	-29%
			24	47	258.750°	-98%	-20%
				48	264.375°	-100%	-10%
	7	13	25	49	270.000°	-100%	0%
				50	275.625°	-100%	10%
			26	51	281.250°	-98%	20%
				52	286.875°	-96%	29%
		14	27	53	292.500°	-92%	38%
				54	298.125°	-88%	47%
			28	55	303.750°	-83%	56%
				56	309.375°	-77%	63%
4	8	15	29	57	315.000°	-71%	71%
				58	320.625°	-63%	77%
			30	59	326.250°	-56%	83%
				60	331.875°	-47%	88%
		16	31	61	337.500°	-38%	92%
				62	343.125°	-29%	96%
			32	63	348.750°	-20%	98%
				64	354.375°	-10%	100%
	1	1	1	1	360.000°	0%	100%

Table 3. Microstepping Relative Current per Step (DIR = 1) (continued)

Non-circular 1/2-step operation is shown in Table 4. This stepping mode consumes more power than circular 1/2-step operation, but provides a higher torque at high motor rpm.

Table 4. Non-Circular 1/2-Stepping Current

NON-CIRCULAR 1/2 STEP	AOUT CURRENT (% FULL-SCALE)	BOUT CURRENT (% FULL-SCALE)	ELECTRICAL ANGLE (°)
1	0	100	0
2	100	100	45
3	100	0	90
4	100	-100	135
5	0	-100	180
6	-100	-100	225
7	-100	0	270
8	-100	100	315





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7.3.4 Current Regulation

The current through the motor windings is regulated by an adjustable fixed-off-time PWM current regulation circuit. When an H-bridge is enabled, current rises through the winding at a rate dependent on the DC voltage, inductance of the winding, and the magnitude of the back EMF present. After the current hits the current chopping threshold, the bridge enters a decay mode for a fixed 20-µs period of time to decrease the current. After the off time expires, the bridge is re-enabled, starting another PWM cycle.

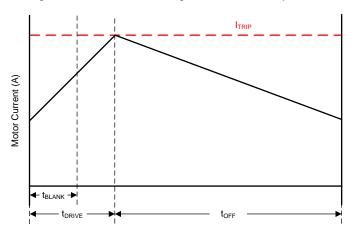


Figure 14. Current Chopping Waveform

The PWM chopping current is set by a comparator which looks at the voltage across current sense FETs in parallel with the low-side drivers. The current sense FETs are biased with a reference current that is the output of a current-mode sine-weighted DAC whose full-scale reference current is set by the current through the RREF pin. An external resistor is placed from the RREF pin to GND in order to set the reference current. In addition, the TRQ pin can further scale the reference current.

The chopping current is calculated as shown in Equation 1.

$$I_{FS} (A) = \frac{A_{RREF} (kA\Omega)}{RREF (k\Omega)} \times TRQ (\%) = \frac{30 (kA\Omega)}{RREF (k\Omega)} \times TRQ (\%)$$

Example: If a 30-k Ω resistor is connected to the RREF pin, the chopping current will be 1 A (TRQ at 100%).

The TRQ pin is the input to a DAC used to scale the output current. The current scalar value for different inputs is shown in Table 5.

•	U U
TRQ	CURRENT SCALAR (TRQ)
0	100%
Z	75%
1	50%

Table 5. Torque DAC Settings

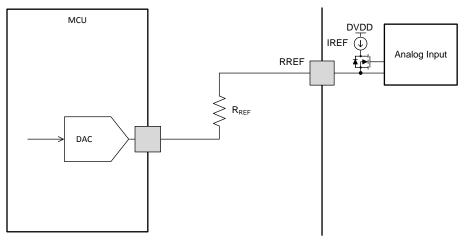
(1)

(2)

7.3.5 Controlling RREF With an MCU DAC

In some cases, the full-scale output current may need to be changed on the fly between many different values, depending on motor speed and loading. The RREF pin reference current can be adjusted in system by tying the RREF resistor to a DAC output instead of GND.

In this mode of operation, as the DAC voltage increases, the reference current will decrease, and therefore, the full-scale current will decrease as well. For proper operation, the output of the DAC should not rise above V_{RREF}.



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Figure 15. Controlling RREF With a DAC

The chopping current as controlled by a DAC is calculated as in Equation 2.

$$I_{FS} (A) = \frac{A_{RREF} (kA\Omega) \times [V_{RREF} (V) - V_{DAC} (V)]}{V_{RREF} (V) \times RREF (k\Omega)} \times TRQ (\%)$$

Example: If a 20-k Ω resistor is connected from the RREF pin to the DAC, and the DAC is outputting 0.74 V, the chopping current will be 600 mA (TRQ at 100%).

RREF can also be adjusted using a PWM signal and low-pass filter.

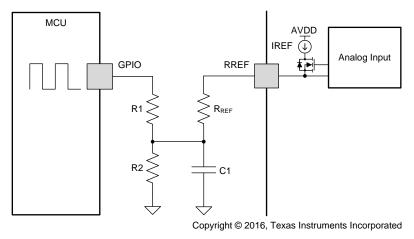


Figure 16. Controlling RREF with a PWM Resource



7.3.6 Decay Modes

The DRV8884 decay mode is selected by setting the quad-level DECAY pin to the voltage range in Table 6.

DECAY	INCREASING STEPS	DECREASING STEPS
100 mV Can be tied to ground	Slow decay	Mixed decay: 30% fast
300 mV, 15 kΩ to GND	Mixed decay: 30% fast	Mixed decay: 30% fast
1.0 V, 45 kΩ to GND	Mixed decay: 60% fast	Mixed decay: 60% fast
2.9 V Can be tied to DVDD	Slow decay	Slow decay

Increasing and decreasing current are defined in Figure 17. For the slow/mixed decay mode, the decay mode is set as slow during increasing current steps and mixed decay during decreasing current steps. In full-step mode, the decreasing steps decay mode is always used.

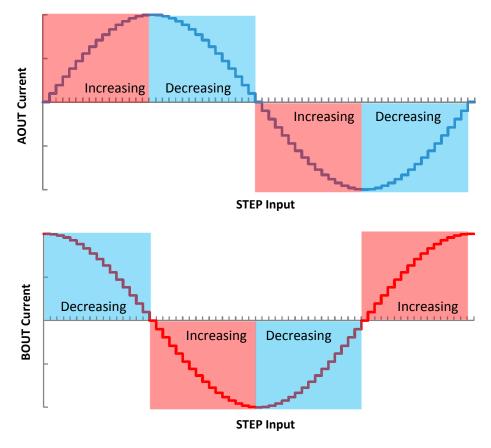


Figure 17. Definition of Increasing and Decreasing Steps





7.3.6.1 Mode 1: Slow Decay for Increasing and Decreasing Current

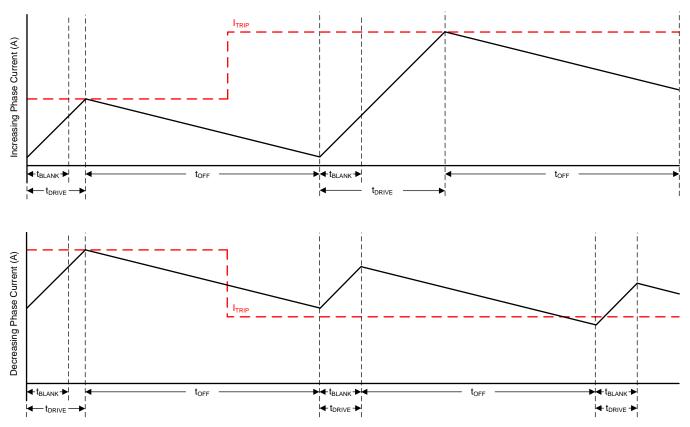
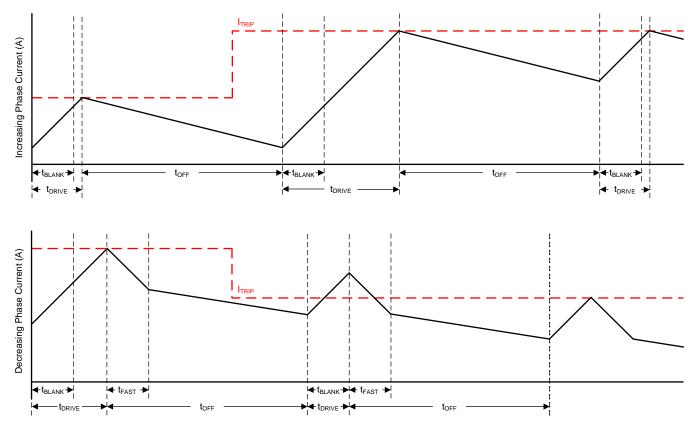


Figure 18. Slow/Slow Decay Mode

During slow decay, both of the low-side FETs of the H-bridge are turned on, allowing the current to be recirculated.

Slow decay exhibits the least current ripple of the decay modes for a given t_{OFF} . However, on decreasing current steps, slow decay takes a long time to settle to the new I_{TRIP} level because the current decreases very slowly.





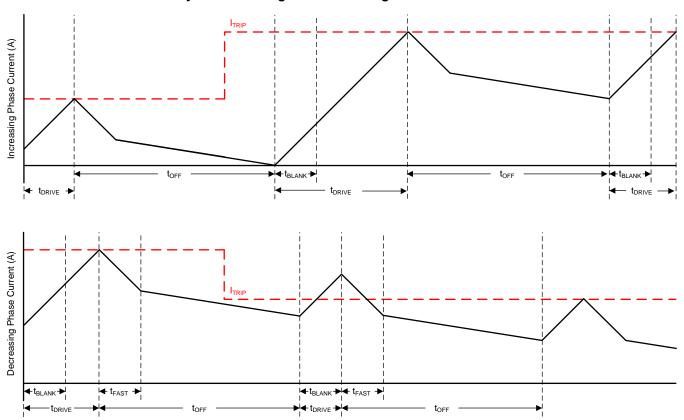
7.3.6.2 Mode 2: Slow Decay for Increasing Current, Mixed Decay for Decreasing Current

Figure 19. Slow/Mixed Decay Mode

Mixed decay begins as fast decay for a time, followed by slow decay for the remainder of t_{OFF}. In this mode, mixed decay only occurs during decreasing current. Slow decay is used for increasing current.

This mode exhibits the same current ripple as slow decay for increasing current, since for increasing current, only slow decay is used. For decreasing current, the ripple is larger than slow decay, but smaller than fast decay. On decreasing current steps, mixed decay settles to the new I_{TRIP} level faster than slow decay.





7.3.6.3 Mode 3: Mixed Decay for Increasing and Decreasing Current

Figure 20. Mixed/Mixed Decay Mode

Mixed decay begins as fast decay for a time, followed by slow decay for the remainder of t_{OFF} . In this mode, mixed decay occurs for both increasing and decreasing current steps.

This mode exhibits ripple larger than slow decay, but smaller than fast decay. On decreasing current steps, mixed decay settles to the new I_{TRIP} level faster than slow decay.

In cases where current is held for a long time (no input in the STEP pin) or at very low stepping speeds, slow decay may not properly regulate current because no back-EMF is present across the motor windings. In this state, motor current can rise very quickly, and requires an excessively large off-time. Increasing/decreasing mixed decay mode allows the current level to stay in regulation when no back-EMF is present across the motor windings.



7.3.7 Blanking Time

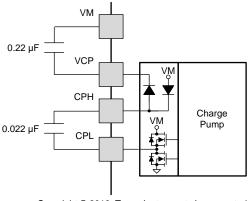
After the current is enabled in an H-bridge, the current sense comparator is ignored for a period of time (t_{BLANK}) before enabling the current sense circuitry. Note that the blanking time also sets the minimum drive time of the PWM. Table 7 shows the blanking time based on the sine table index and the torque DAC setting. Note that the torque DAC index is not the same as one step as given in Table 3.

Table 7. Adaptive Blanking Time over Torque DAC and Microsteps

	t _{blank} = 1.5 μs	t _{blank} = 1.0 μs									
SINE INDEX	T	TORQUE DAC (TRQ)									
SINE INDEX	100%	75%	50%								
16	100%	75%	50%								
15	98%	73.5	49%								
14	96%	72%	48%								
13	92%	69%	46%								
12	88%	66%	44%								
11	83%	62.3%	41.5%								
10	77%	57.8%	38.5%								
9	71%	53.3%	35.5%								
8	63%	47.3%	31.5%								
7	56%	42%	28%								
6	47%	35.3	23.5%								
5	38%	28.5	19%								
4	29%	21.8%	14.5%								
3	20%	15%	10%								
2	10%	7.5%	5%								
1	0%	0%	0%								

7.3.8 Charge Pump

A charge pump is integrated in order to supply a high-side NMOS gate drive voltage. The charge pump requires a capacitor between the VM and VCP pins. Additionally, a low-ESR ceramic capacitor is required between pins CPH and CPL.



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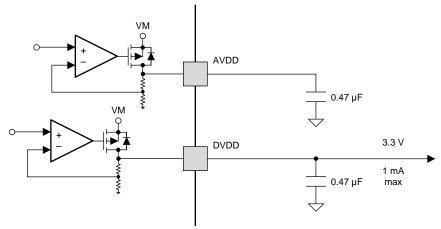
Figure 21. Charge Pump Diagram

7.3.9 LDO Voltage Regulator

An LDO regulator is integrated into the DRV8884. DVDD can be used to provide a reference voltage. For proper operation, bypass DVDD to GND using a ceramic capacitor.

The DVDD output is nominally 3.3 V. When the DVDD LDO current load exceeds 1 mA, the output voltage drops significantly.

The AVDD pin also requires a bypass capacitor to GND. This LDO is for DRV8884 internal use only.



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Figure 22. LDO Diagram

If a digital input needs to be tied permanently high (that is, Mx, DECAY, or TRQ), it is preferable to tie the input to DVDD instead of an external regulator. This saves power when VM is not applied or in sleep mode; DVDD is disabled and current will not be flowing through the input pulldown resistors. For reference, logic level inputs have a typical pulldown of 100 k Ω , and tri-level inputs have a typical pulldown of 60 k Ω .

7.3.10 Logic and Multi-Level Pin Diagrams

Figure 23 gives the input structure for logic-level pins STEP, DIR, ENABLE, nSLEEP, and M1.

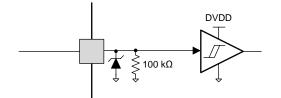
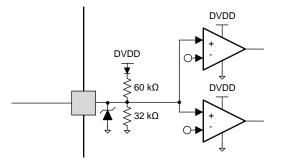


Figure 23. Logic-level Input Pin Diagram

Tri-level logic pins M0 and TRQ have the following structure shown in Figure 24.







Quad-level logic pin DECAY has the following structure shown in Figure 25.

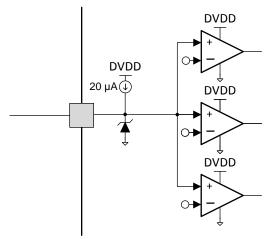


Figure 25. Quad-level Input Pin Diagram

7.3.11 Protection Circuits

The DRV8884 is fully protected against undervoltage, charge pump undervoltage, overcurrent, and overtemperature events.

7.3.11.1 VM UVLO

If at any time the voltage on the VM pin falls below the VM UVLO threshold voltage (V_{UVLO}), all FETs in the Hbridge will be disabled, the charge pump will be disabled, the logic will be reset, the DVDD regulator is disabled, and the nFAULT pin will be driven low. Operation resumes when VM rises above the UVLO threshold. The nFAULT pin is released after operation has resumed. Decreasing VM below this undervoltage threshold will reset the indexer position.

7.3.11.2 VCP Undervoltage Lockout (CPUV)

If at any time the voltage on the VCP pin falls below the charge pump UVLO threshold voltage, all FETs in the Hbridge will be disabled and the nFAULT pin will be driven low. Operation resumes when VCP rises above the CPUV threshold. The nFAULT pin is released after operation has resumed.

7.3.11.3 Overcurrent Protection (OCP)

An analog current limit circuit on each FET limits the current through the FET by removing the gate drive. If this analog current limit persists for longer than t_{OCP}, all FETs in the H-bridge will be disabled and nFAULT will be driven low.

The driver is re-enabled after the OCP retry period (t_{RETRY}) has passed. nFAULT becomes high again after the retry time. If the fault condition is still present, the cycle repeats. If the fault is no longer present, normal operation resumes and nFAULT remains deasserted.

7.3.11.4 Thermal Shutdown (TSD)

If the die temperature exceeds safe limits, all FETs in the H-bridge will be disabled and the nFAULT pin will be driven low. After the die temperature has fallen to a safe level, operation automatically resumes. The nFAULT pin is released after operation has resumed.

FAULT	CONDITION	ERROR REPORT	H-BRIDGE	CHARGE PUMP	INDEXER	DVDD	RECOVERY
VM undervoltage (UVLO)	VM < V _{UVLO} (max 7.8 V)	nFAULT	Disabled	Disabled	Disabled	Disabled	VM > V _{UVLO} (max 8.0 V)

Table 8. Fault Condition Summary



FAULT	CONDITION	ERROR REPORT	H-BRIDGE	CHARGE PUMP	INDEXER	DVDD	RECOVERY					
VCP undervoltage (CPUV)	VCP < V _{CPUV} (typ VM + 2.0 V)	nFAULT	Disabled	Operating	Operating	Operating	VCP > V _{CPUV} (typ VM + 2.7 V)					
Overcurrent (OCP)	I _{OUT} > I _{OCP} (min 1.7 A)	nFAULT	Disabled	Operating	Operating	Operating	t _{RETRY}					
Thermal Shutdown (TSD)	T _J > T _{TSD} (min 150°C)	nFAULT	Disabled	Operating	Operating	Operating	T _J < T _{TSD} – T _{HYS} (T _{HYS} typ 20°C)					

Table 8. Fault Condition Summary (continued)

7.4 Device Functional Modes

The DRV8884 is active unless the nSLEEP pin is brought logic low. In sleep mode, the charge pump is disabled, the H-bridge FETs are disabled Hi-Z, and the V3P3 regulator is disabled. Note that t_{SLEEP} must elapse after a falling edge on the nSLEEP pin before the device is in sleep mode. The DRV8884 is brought out of sleep mode automatically if nSLEEP is brought logic high. Note that t_{WAKE} must elapse before the outputs change state after wake-up.

TI recommends to keep the STEP pin logic low when coming out of nSLEEP or when applying power.

If the ENABLE pin is brought logic low, the H-bridge outputs are disabled, but the internal logic will still be active. A rising edge on STEP will advance the indexer, but the outputs will not change state until ENABLE is asserted.

	CONDITION	H-BRIDGE	CHARGE PUMP	INDEXER	V3P3
Operating	8 V < VM < 40 V nSLEEP pin = 1 ENABLE pin = 1	Operating	Operating	Operating	Operating
Disabled	8 V < VM < 40 V nSLEEP pin = 1 ENABLE pin = 0	Disabled	Operating	Operating	Operating
Sleep mode	8 V < VM < 40 nSLEEP pin = 0	Disabled	Disabled	Disabled	Disabled
	VM undervoltage (UVLO)	Disabled	Disabled	Disabled	Disabled
	VCP undervoltage (CPUV)	Disabled	Operating	Operating	Operating
Fault encountered	Overcurrent (OCP)	Disabled	Operating	Operating	Operating
	Thermal shutdown (TSD)	Disabled	Operating	Operating	Operating

Table 9. Functional Modes Summary



8 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

The DRV8884 is used in bipolar stepper control.

8.2 Typical Application

The following design procedure can be used to configure the DRV8884.

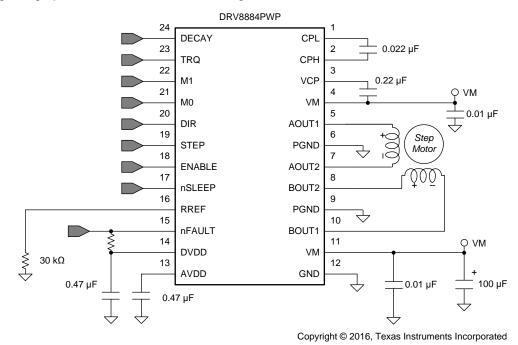


Figure 26. Typical Application Schematic

8.2.1 Design Requirements

Table 10 gives design input parameters for system design.

DESIGN PARAMETER	REFERENCE	EXAMPLE VALUE								
Supply voltage	VM	24 V								
Motor winding resistance	RL	2.6 Ω/phase								
Motor winding inductance	L	1.4 mH/phase								
Motor full step angle	θ_{step}	1.8°/step								
Target microstepping level	n _m	1/8 step								
Target motor speed	V	120 rpm								
Target full-scale current	I _{FS}	1.0 A								

Table 10. Design Parameters

8.2.2 Detailed Design Procedure

8.2.2.1 Stepper Motor Speed

The first step in configuring the DRV8884 requires the desired motor speed and microstepping level. If the target application requires a constant speed, then a square wave with frequency f_{step} must be applied to the STEP pin.

If the target motor speed is too high, the motor will not spin. Make sure that the motor can support the target speed.

For a desired motor speed (v), microstepping level (n_m), and motor full step angle (θ_{step}),

$$f_{\text{step}} (\text{steps / s}) = \frac{v (\text{rpm}) \times 360 (^{\circ} / \text{rot})}{\theta_{\text{step}} (^{\circ} / \text{step}) \times n_{\text{m}} (\text{steps / microstep}) \times 60 (\text{s / min})}$$
(3)

 θ_{step} can be found in the stepper motor data sheet, or written on the motor itself.

For the DRV8884, the microstepping level is set by the Mx pins and can be any of the settings in Table 11. Higher microstepping will mean a smother motor motion and less audible noise, but will increase switching losses and require a higher f_{step} to achieve the same motor speed.

M1	MO	STEP MODE
0	0	Full step (2-phase excitation) with 71% current
0	1	1/16 step
1	0	1/2 step
1	1	1/4 step
0	Z	1/8 step
1	Z	Non-circular 1/2 step

Table 11. Microstepping Indexer Settings

Example: Target 120 rpm at 1/8 microstep mode. The motor is 1.8°/step

$$f_{\text{step}} (\text{steps/s}) = \frac{120 \text{ rpm} \times 360^{\circ}/\text{ rot}}{1.8^{\circ}/\text{ steps} \times 1/8 \text{ steps}/\text{ microstep} \times 60 \text{ s}/\text{min}} = 3.2 \text{ kHz}$$
(4)

8.2.2.2 Current Regulation

In a stepper motor, the full-scale current (I_{FS}) is the maximum current driven through either winding. This quantity will depend on the RREF resistor and the TRQ setting. During stepping, I_{FS} defines the current chopping threshold (I_{TRIP}) for the maximum current step.

$$I_{FS}(A) = \frac{A_{RREF}(kA\Omega)}{RREF(k\Omega)} = \frac{30 (kA\Omega) \times TRQ\%}{RREF(k\Omega)}$$
(5)

Note that I_{FS} must also follow Equation 6 in order to avoid saturating the motor. VM is the motor supply voltage, and R_1 is the motor winding resistance.

$$I_{FS} (A) < \frac{VM(V)}{R_L (\Omega) + 2 \times R_{DS(ON)} (\Omega)}$$
(6)

8.2.2.3 Decay Modes

The DRV8884 supports three different decay modes: slow decay, slow/mixed and all mixed decay. The current through the motor windings is regulated using an adjustable fixed-time-off scheme. This means that after any drive phase, when a motor winding current has hit the current chopping threshold (I_{TRIP}), the DRV8884 will place the winding in one of the three decay modes for t_{OFF}. After t_{OFF}, a new drive phase starts.

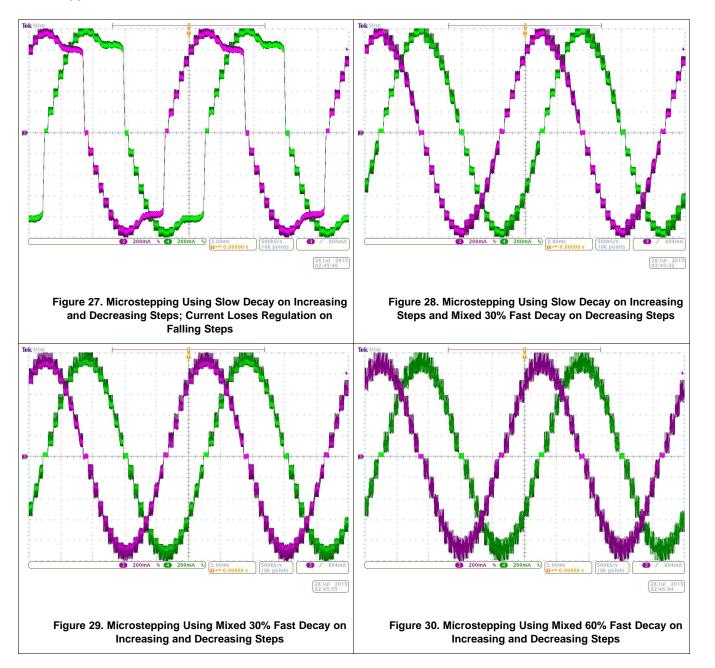
The blanking time t_{BLANK} defines the minimum drive time for the PWM current chopping. I_{TRIP} is ignored during t_{BLANK}, so the winding current may overshoot the trip level.



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8.2.3 Application Curves





9 Power Supply Recommendations

The DRV8884 is designed to operate from an input voltage supply (VM) range between 8 and 35 V. A $0.01-\mu$ F ceramic capacitor rated for VM must be placed at each VM pin as close to the DRV8884 as possible. In addition, a bulk capacitor must be included on VM.

9.1 Bulk Capacitance

Having appropriate local bulk capacitance is an important factor in motor drive system design. It is generally beneficial to have more bulk capacitance, while the disadvantages are increased cost and physical size.

The amount of local capacitance needed depends on a variety of factors, including:

- · The highest current required by the motor system
- · The power supply's capacitance and ability to source current
- · The amount of parasitic inductance between the power supply and motor system
- The acceptable voltage ripple
- The type of motor used (brushed DC, brushless DC, stepper)
- The motor braking method

The inductance between the power supply and motor drive system will limit the rate current can change from the power supply. If the local bulk capacitance is too small, the system will respond to excessive current demands or dumps from the motor with a change in voltage. When adequate bulk capacitance is used, the motor voltage remains stable and high current can be quickly supplied.

The data sheet generally provides a recommended value, but system-level testing is required to determine the appropriate sized bulk capacitor.

The voltage rating for bulk capacitors should be higher than the operating voltage, to provide margin for cases when the motor transfers energy to the supply.

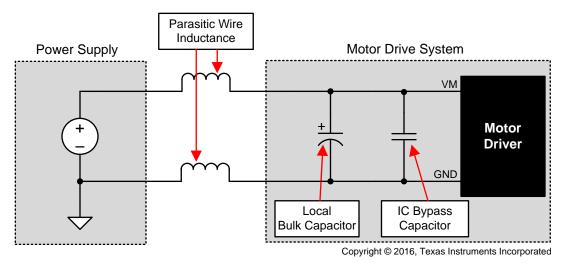


Figure 31. Example Setup of Motor Drive System With External Power Supply



10 Layout

10.1 Layout Guidelines

The VM terminal should be bypassed to GND using a low-ESR ceramic bypass capacitor with a recommended value of 0.01 μ F rated for VM. This capacitor should be placed as close to the VM pin as possible with a thick trace or ground plane connection to the device GND pin.

The VM pin must be bypassed to ground using a bulk capacitor rated for VM. This component may be an electrolytic.

A low-ESR ceramic capacitor must be placed in between the CPL and CPH pins. TI recommends a value of 0.022 µF rated for VM. Place this component as close as possible to the pins.

A low-ESR ceramic capacitor must be placed in between the VM and VCP pins. TI recommends a value of 0.22 μ F rated for 16 V. Place this component as close as possible to the pins.

Bypass AVDD and DVDD to ground with a ceramic capacitor rated 6.3 V. Place this bypassing capacitor as close as possible to the pin.

10.2 Layout Example

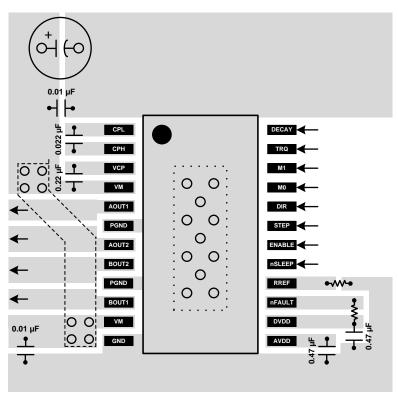


Figure 32. Layout Recommendation

TEXAS INSTRUMENTS

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11 器件和文档支持

11.1 文档支持

11.1.1 相关文档

- 德州仪器 (TI), 《电流再循环和衰减模式》应用报告
- 德州仪器 (TI), 《计算电机驱动器的功耗》应用报告
- 德州仪器 (TI),《使用数模转换器 (DAC) 调整满量程电流》应用报告
- 德州仪器 (TI), 《DRV8884 评估模块 (EVM) 用户指南》
- 德州仪器 (TI), 《PowerPAD™ 热增强型封装》应用报告
- 德州仪器 (TI), 《PowerPAD™ 速成》应用报告
- 德州仪器 (TI), 《了解电机驱动器电流额定值》应用报告

11.2 接收文档更新通知

要接收文档更新通知,请导航至 TI.com.cn 上的器件产品文件夹。单击右上角的通知我进行注册,即可每周接收产品信息更改摘要。有关更改的详细信息,请查看任何已修订文档中包含的修订历史记录。

11.3 社区资源

下列链接提供到 TI 社区资源的连接。链接的内容由各个分销商"按照原样"提供。这些内容并不构成 TI 技术规范, 并且不一定反映 TI 的观点;请参阅 TI 的 《使用条款》。

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设计支持 **71 参考设计支持** 可帮助您快速查找有帮助的 E2E 论坛、设计支持工具以及技术支持的联系信息。

11.4 商标

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11.5 静电放电警告

这些装置包含有限的内置 ESD 保护。存储或装卸时,应将导线一起截短或将装置放置于导电泡棉中,以防止 MOS 门极遭受静电损 伤。

11.6 术语表

SLYZ022 — TI 术语表。

这份术语表列出并解释术语、缩写和定义。

12 机械、封装和可订购信息

以下页面包含机械、封装和可订购信息。这些信息是指定器件的最新可用数据。数据如有变更,恕不另行通知,且 不会对此文档进行修订。如需获取此数据表的浏览器版本,请查阅左侧的导航栏。



PACKAGING INFORMATION

Orderable Device	Status	Package Type	•	Pins	•	Eco Plan	Lead finish/	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	Ball material	(3)		(4/5)	
	-						(6)				
DRV8884PWP	ACTIVE	HTSSOP	PWP	24	60	RoHS & Green	NIPDAU	Level-3-260C-168 HR	-40 to 125	DRV8884	Samples
DRV8884PWPR	ACTIVE	HTSSOP	PWP	24	2000	RoHS & Green	NIPDAU	Level-3-260C-168 HR	-40 to 125	DRV8884	Samples
DRV8884RHRR	ACTIVE	WQFN	RHR	28	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	DRV8884	Samples
DRV8884RHRT	ACTIVE	WQFN	RHR	28	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	DRV8884	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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STRUMENTS

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DRV8884PWPR	HTSSOP	PWP	24	2000	330.0	16.4	6.95	8.3	1.6	8.0	16.0	Q1
DRV8884RHRR	WQFN	RHR	28	3000	330.0	12.4	3.8	5.8	1.2	8.0	12.0	Q1
DRV8884RHRT	WQFN	RHR	28	250	180.0	12.4	3.8	5.8	1.2	8.0	12.0	Q1



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PACKAGE MATERIALS INFORMATION

3-Jun-2022



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
DRV8884PWPR	HTSSOP	PWP	24	2000	350.0	350.0	43.0
DRV8884RHRR	WQFN	RHR	28	3000	367.0	367.0	35.0
DRV8884RHRT	WQFN	RHR	28	250	210.0	185.0	35.0

TEXAS INSTRUMENTS

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3-Jun-2022

TUBE



- B - Alignment groove width

*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	Τ (μm)	B (mm)
DRV8884PWP	PWP	HTSSOP	24	60	530	10.2	3600	3.5

PWP 24

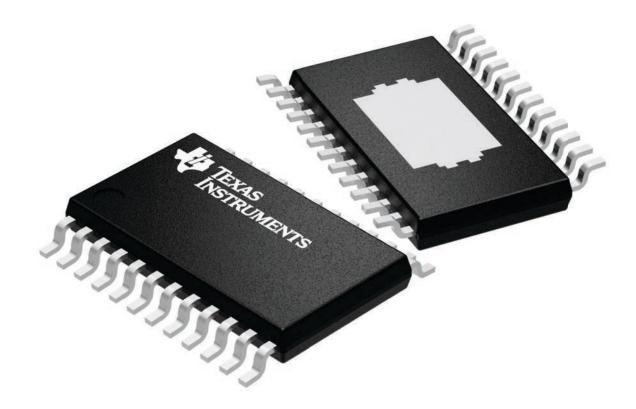
GENERIC PACKAGE VIEW

PowerPAD[™] TSSOP - 1.2 mm max height

PLASTIC SMALL OUTLINE

4.4 x 7.6, 0.65 mm pitch

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



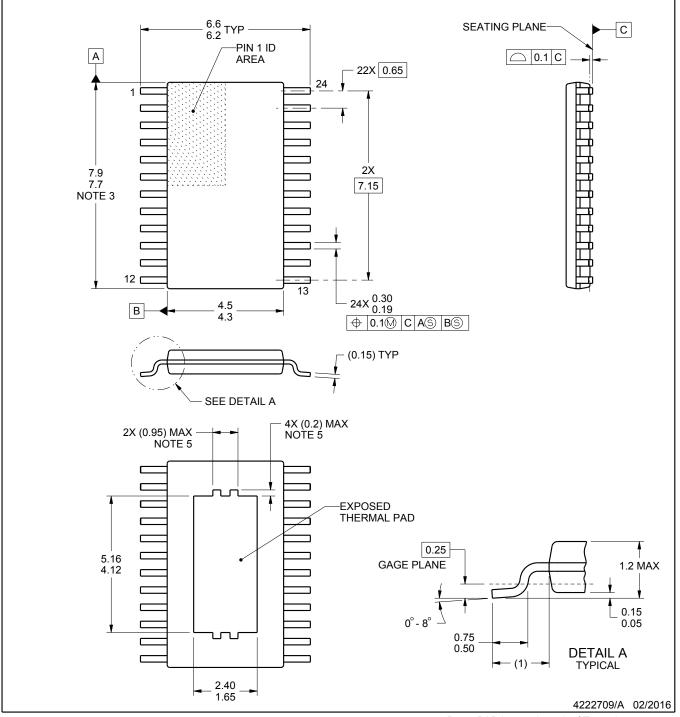


PACKAGE OUTLINE

PWP0024B

PowerPAD[™] TSSOP - 1.2 mm max height

PLASTIC SMALL OUTLINE



NOTES:

PowerPAD is a trademark of Texas Instruments.

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side. 4. Reference JEDEC registration MO-153.
- 5. Features may not be present and may vary.

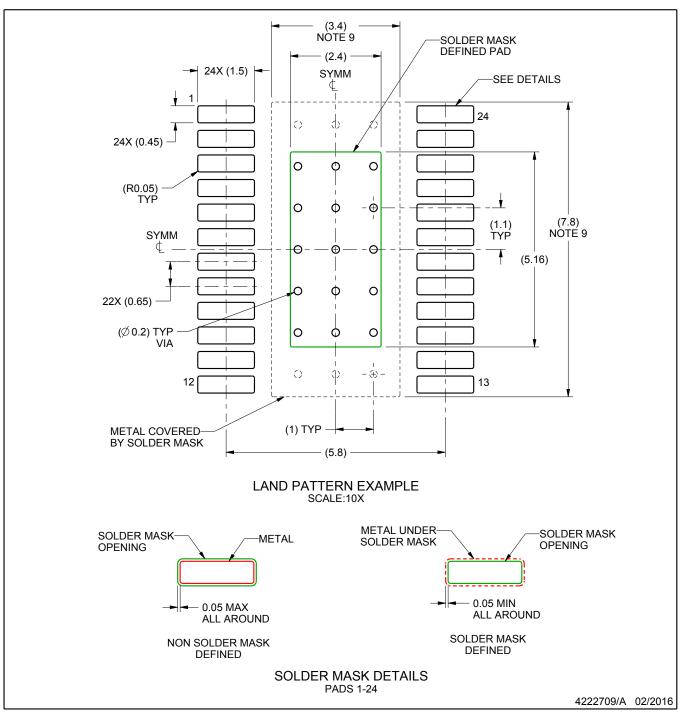


PWP0024B

EXAMPLE BOARD LAYOUT

PowerPAD[™] TSSOP - 1.2 mm max height

PLASTIC SMALL OUTLINE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

 This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature numbers SLMA002 (www.ti.com/lit/slma002) and SLMA004 (www.ti.com/lit/slma004).

9. Size of metal pad may vary due to creepage requirement.

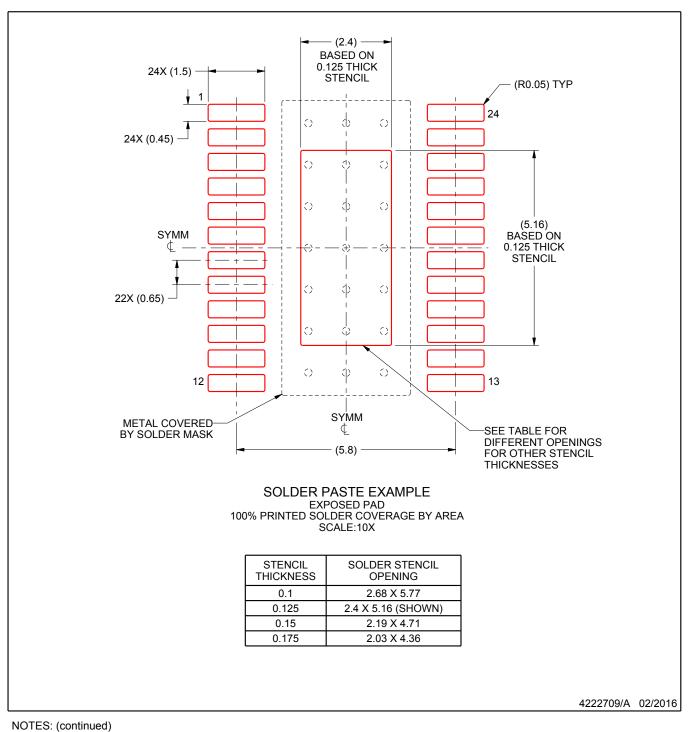


PWP0024B

EXAMPLE STENCIL DESIGN

PowerPAD[™] TSSOP - 1.2 mm max height

PLASTIC SMALL OUTLINE



10. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

11. Board assembly site may have different recommendations for stencil design.



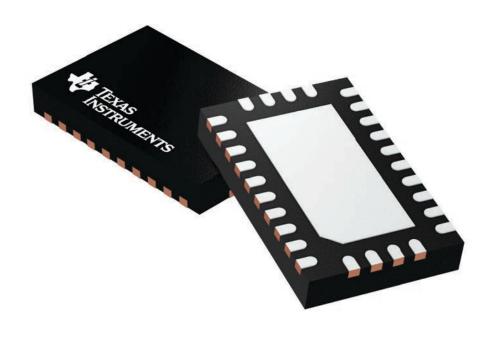
RHR 28

3.5 x 5.5, 0.5 mm pitch

GENERIC PACKAGE VIEW

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



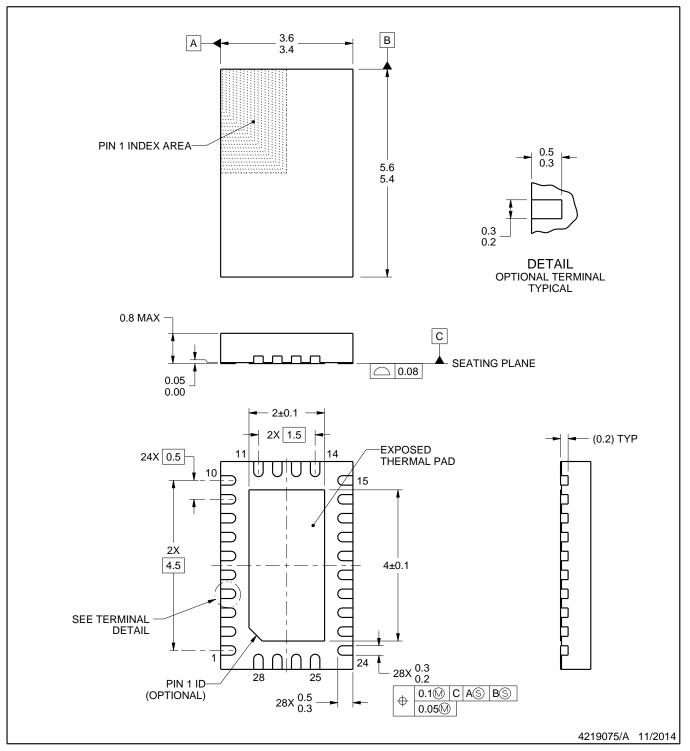
RHR0028A



PACKAGE OUTLINE

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

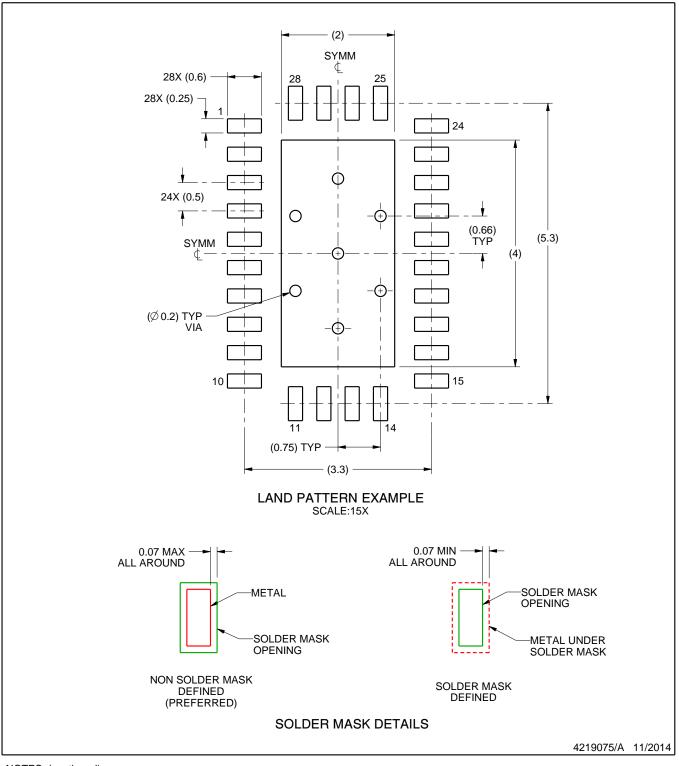


RHR0028A

EXAMPLE BOARD LAYOUT

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

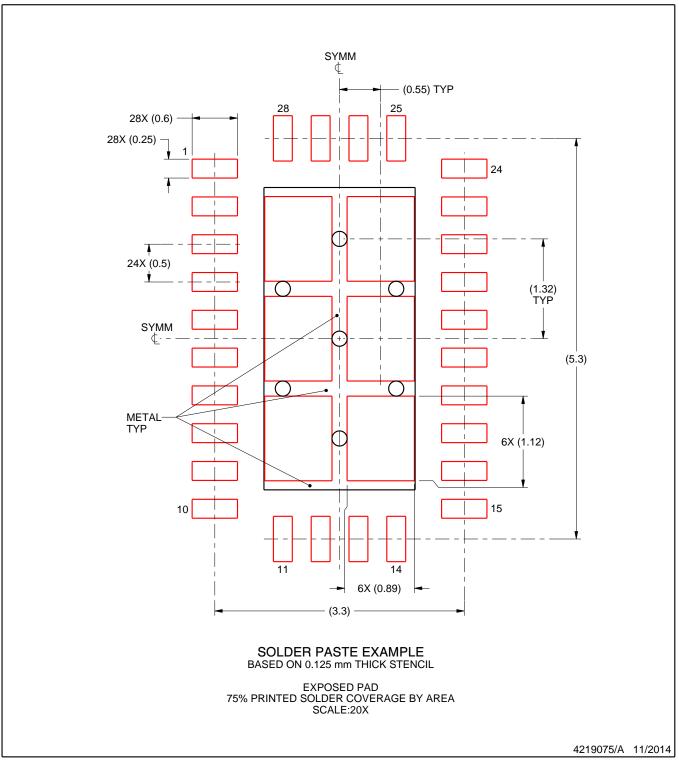


RHR0028A

EXAMPLE STENCIL DESIGN

WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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